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# Inspection of Pipelines using High-Resolution MWM<sup>®</sup> and MR-MWM-Arrays

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*API Pipeline Conference  
April 16-17, 2013  
Loews Coronado Bay, San Diego, CA*

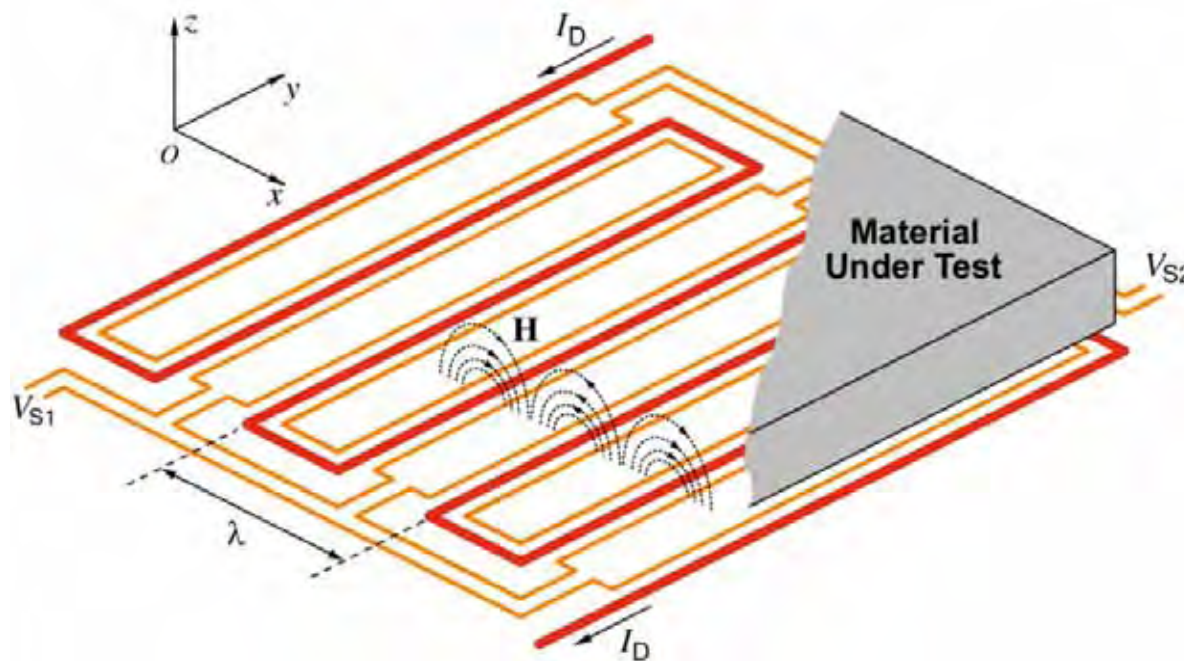
# Outline

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- **MWM-Array Technology overview**
- **Oil & Gas Applications**
  - Pipe wall thickness measurement through coatings/insulation
  - Underwater inspections (shallow water and deepsea) for pipe wall thickness measurement
  - SCC mapping and crack depth estimation
  - Characterization of pitting in stainless steel tubing
  - Permanently mounted sensors for continuous monitoring
  - In-line inspection (ILI)

# MWM & MWM-Array Background

- Designed using winding constructs that are easy to model
- Enables response prediction for typical pipe/coating constructs
- Magnetic field-based method
- Variations in magnetic field reflect test material condition



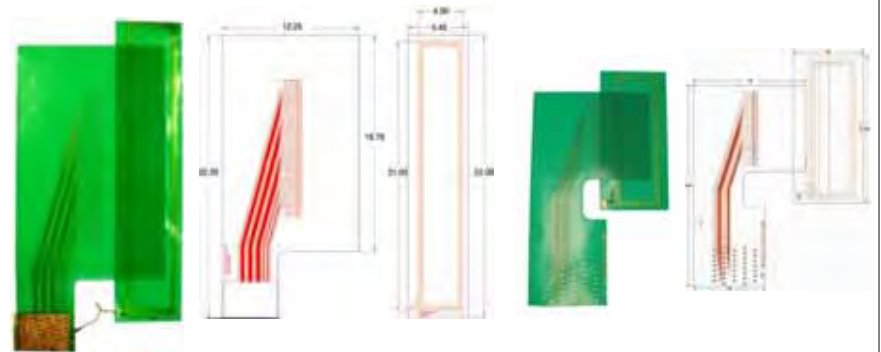
# MWM-Array Examples

**MWM-Array dimensions can be adjusted for the application**

**e.g., high spatial resolution or imaging through thick coatings**

VWA001

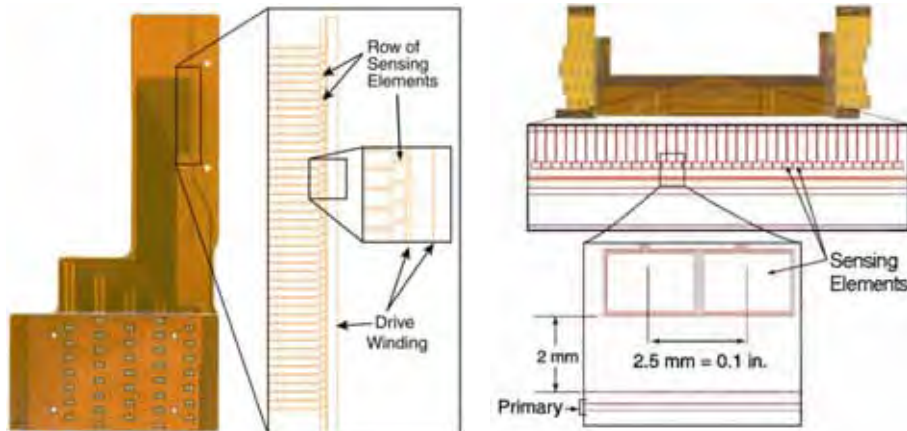
VWA003



**Thin insulation, external corrosion**

FA28

FA24

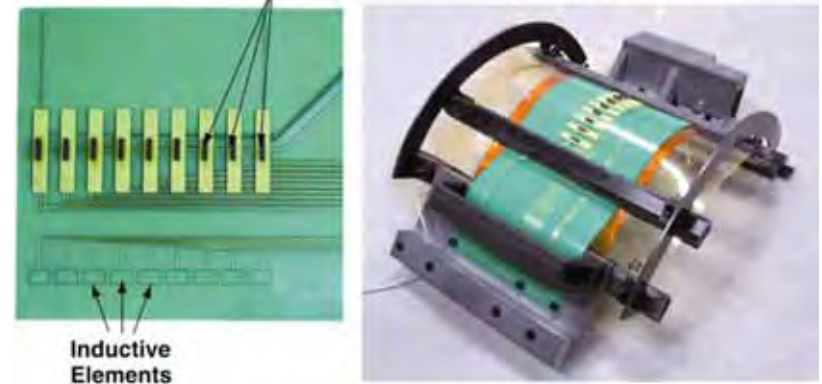


**High resolution, no insulation**

**Generation 3 MR-MWM-Arrays**

MR Elements

Prototype Scanner Tool



**Thick insulation, internal & external corrosion**

# MWM-Array Sensor Selection

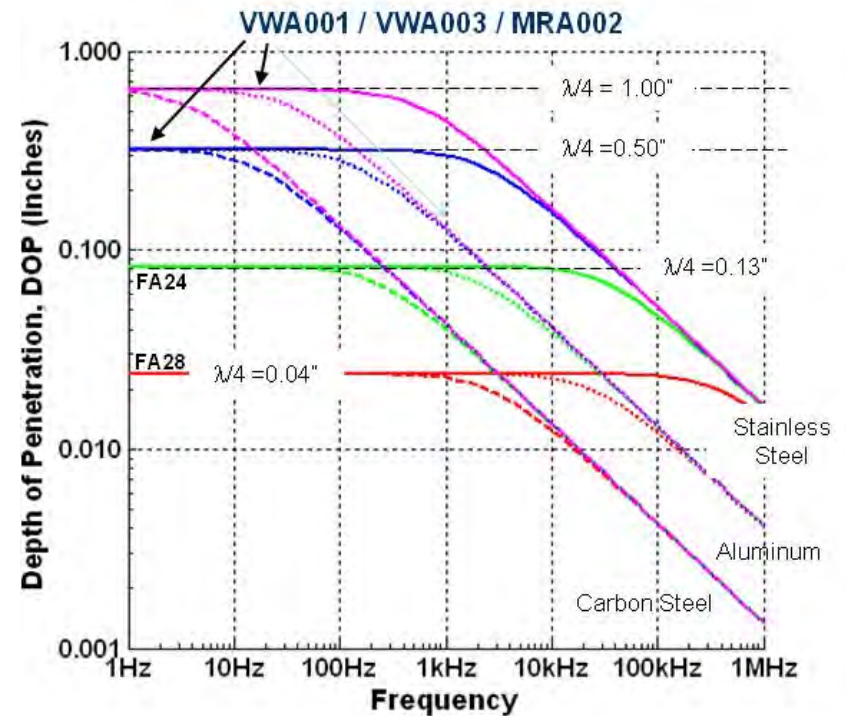
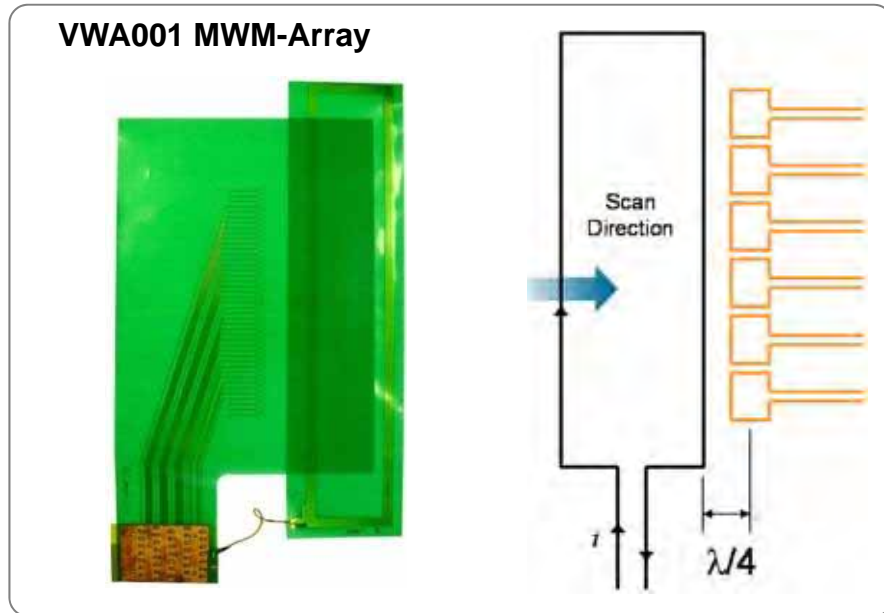
- Decay rate determined by skin depth at high freq. and sensor dimensions at low freq.
- Large dimensions needed for thick coatings
- Low frequencies needed to penetrate through steel pipe wall

Depth of Penetration =  $1/\text{Re}(\Gamma_n)$

Low Frequency Limit =  $\frac{\lambda}{2\pi}$

$$\Gamma_n = \sqrt{(2\pi n / \lambda)^2 + j2 / \delta^2}$$

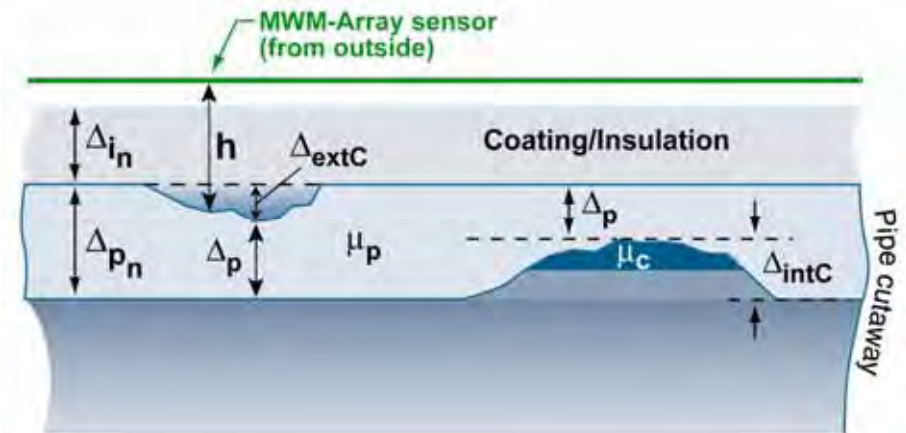
Skin depth:  $\delta = \sqrt{\frac{1}{\pi f \mu \sigma}}$



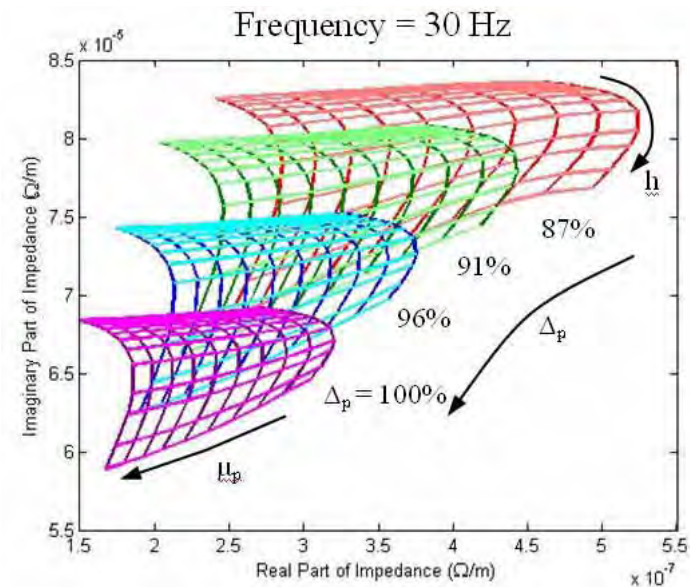
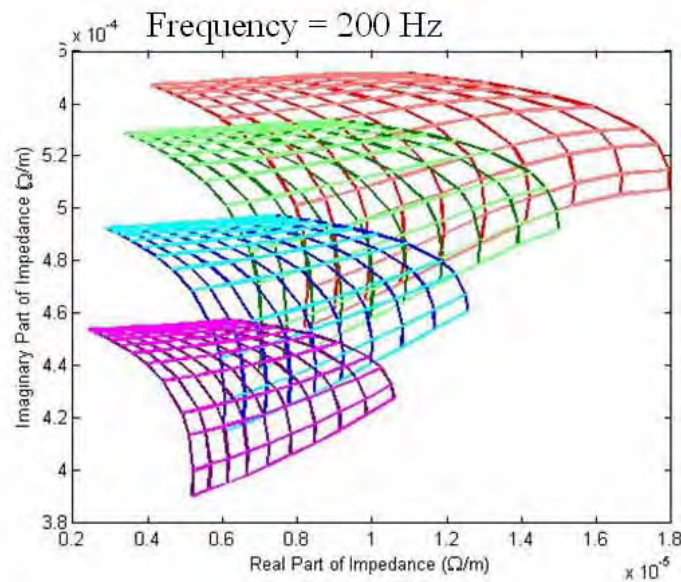


# HyperLattices: Precomputed Sensor Response Databases

- Rapid means for converting multiple frequency array data into material and geometric properties
- Grids (two-unknown databases), Lattices (3-unknowns), Hyperlattices (4+ unknowns) are generated and stored in advance



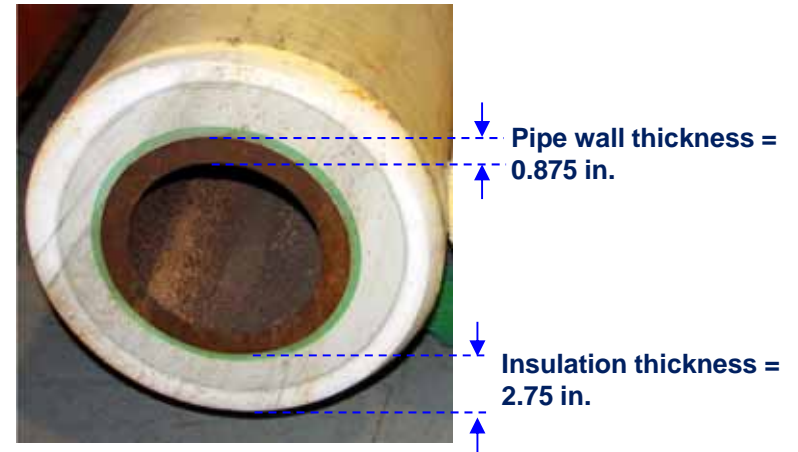
## Example Lattices



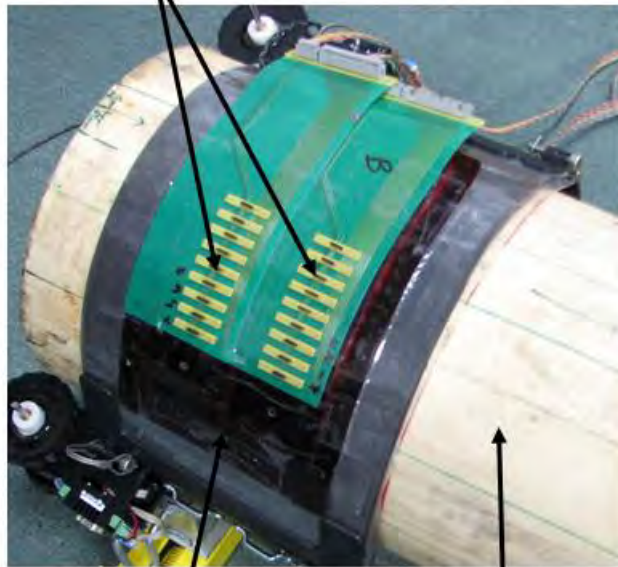
# Internal Corrosion Imaging

## MR-MWM-Array Imaging of Heavy Wet Insulated Risers

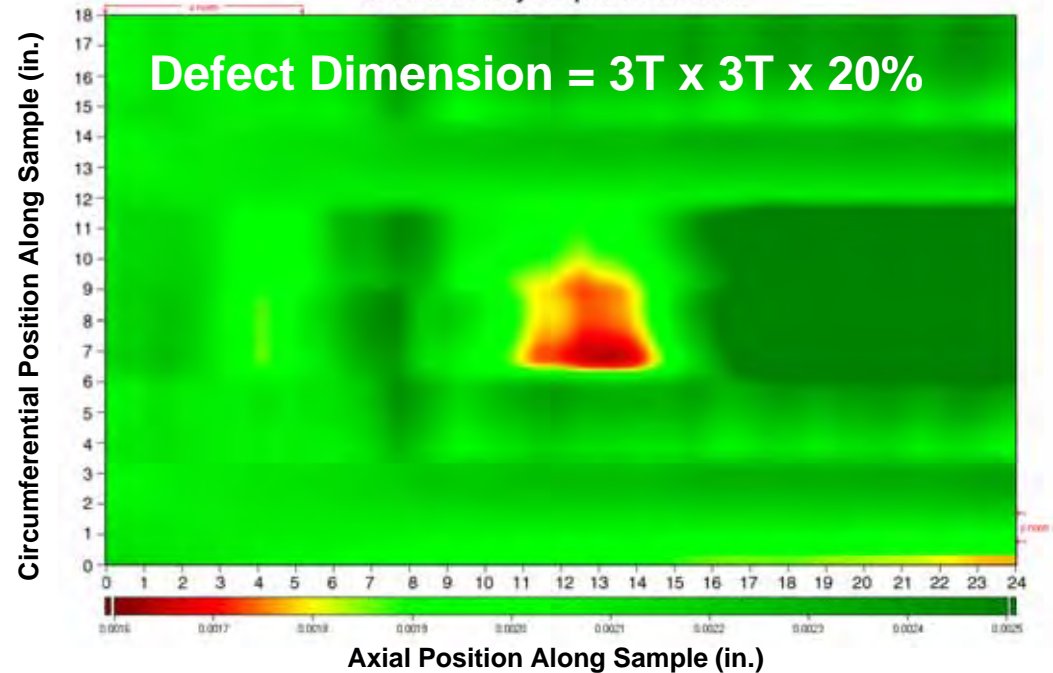
- Performed measurements under a related effort on heavy wet insulated riser samples
- Detection of internal corrosion through *2.75 inch* insulation and *0.875 inch* pipe wall



MR-MWM-Array Sensors

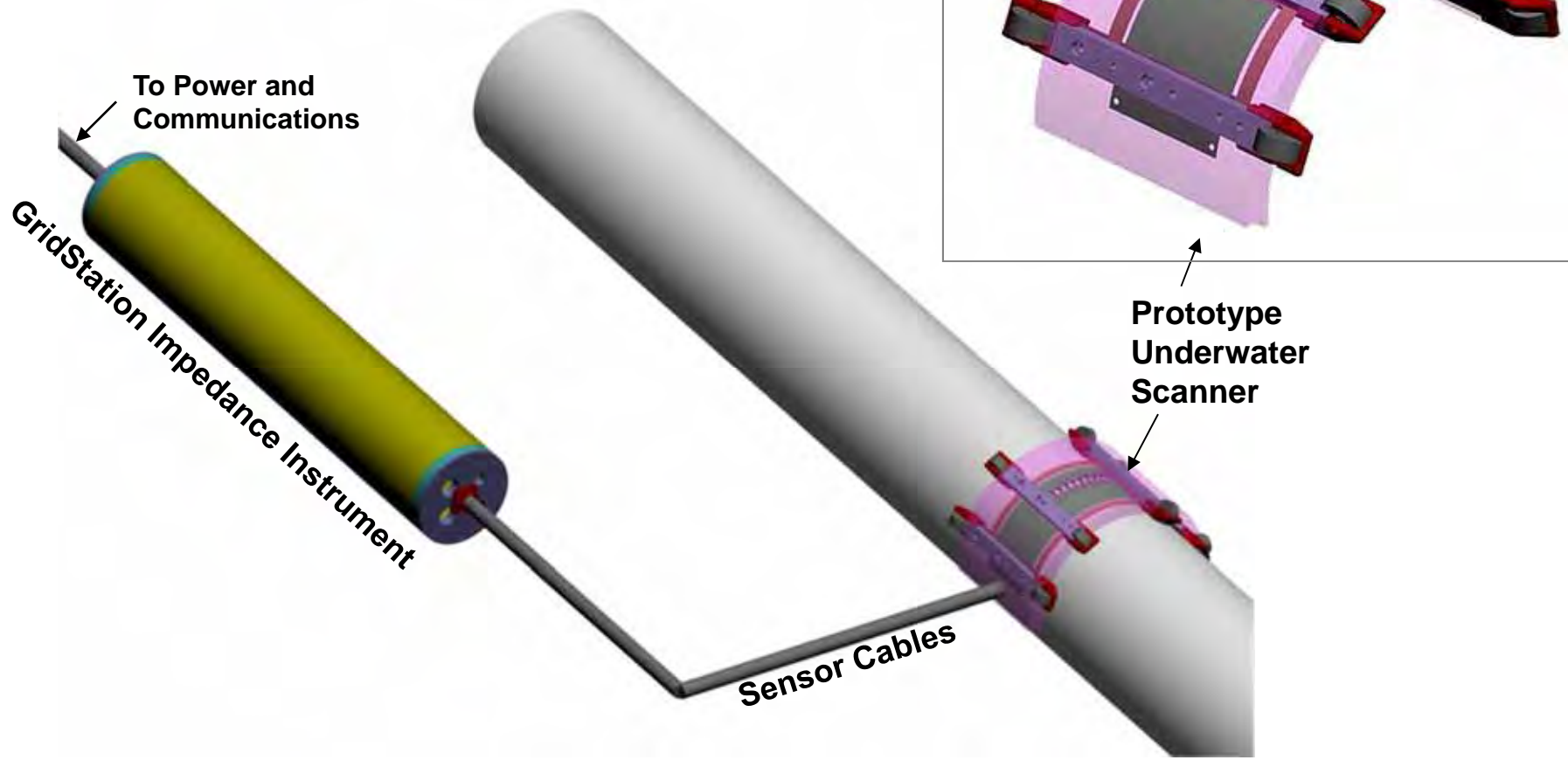


MR-MWM-Array Response at 3.75 Hz



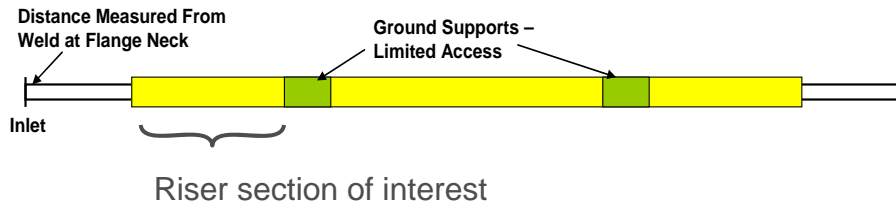
# Underwater Scanning System

Under Development

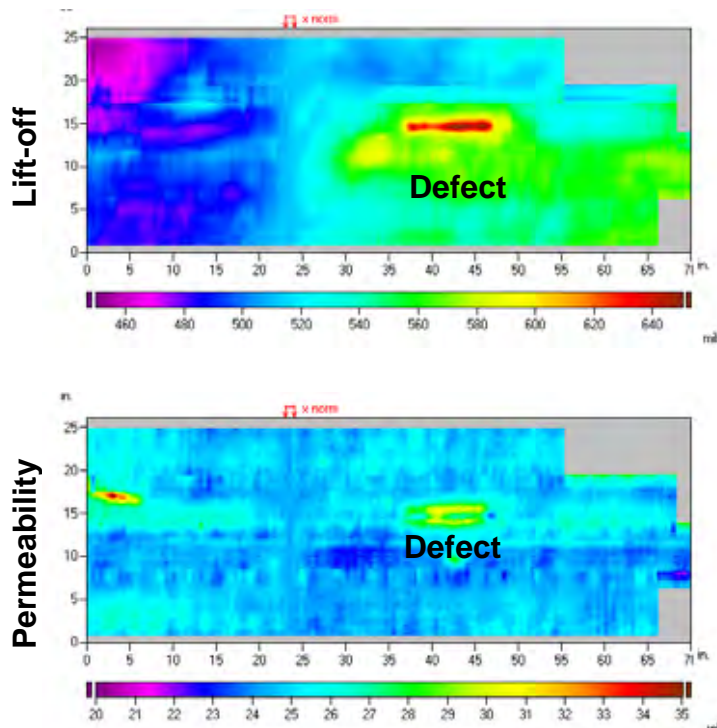




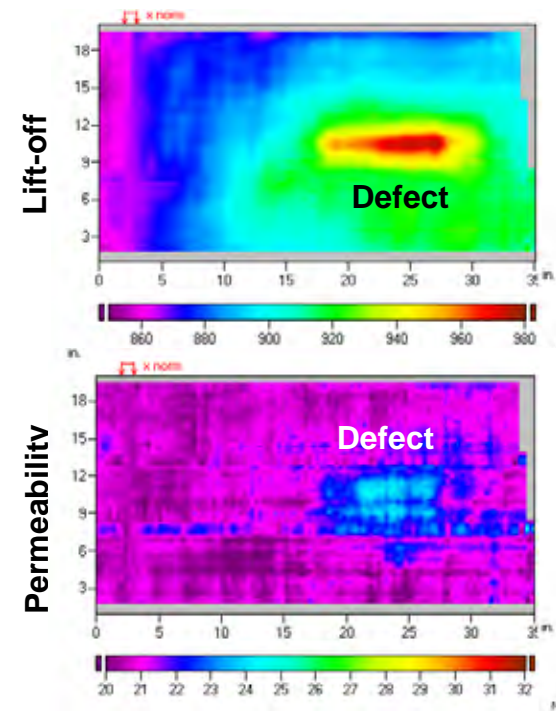
# Previous CUI Results Using VWA001 MWM-Arrays



0.5 in. coating



1.0 in. coating



# Capability Demonstrations

## MR-MWM-Arrays through weather jacket

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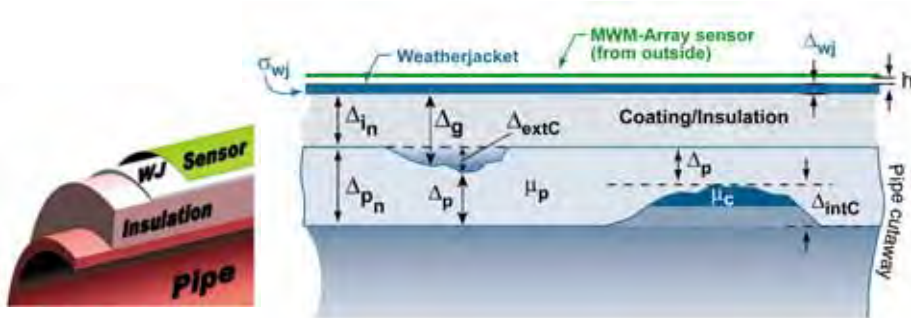
- Performed field trials in 2011 and 2012
- 4 field trials completed to date, more planned for 2013
- Trials designed to guide future development
- Successfully demonstrated a flexible scanner on multiple locations and pipe diameters



# MWM-Array Inspection for CUI

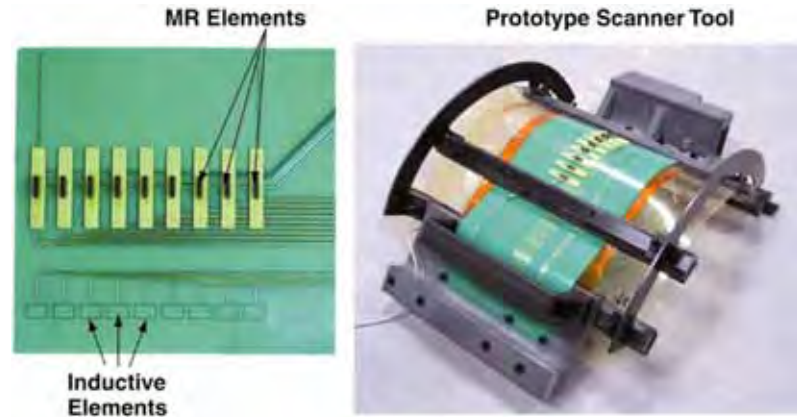
## Through weather jacket

### Problem Definition



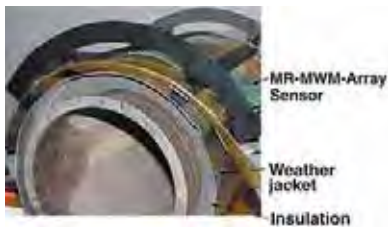
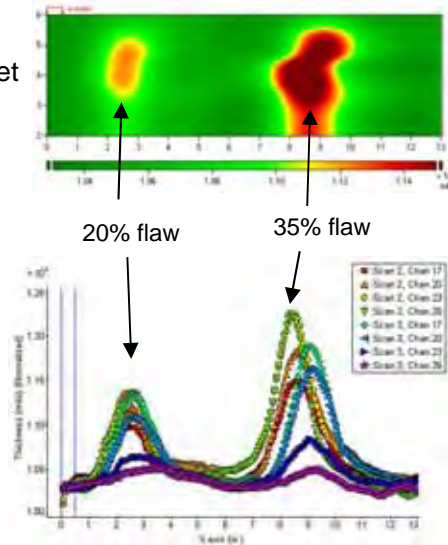
$$\Delta_g = \Delta_{in} + \Delta_{extC}, \Delta_p = \text{wall thickness}$$

### JENTEK MR-MWM-Array

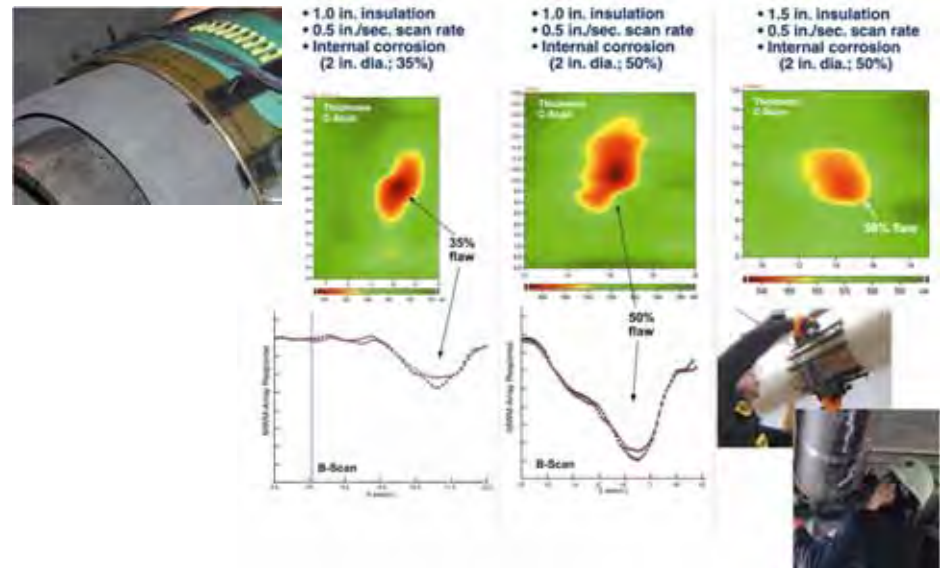


### Detection of External Corrosion

- 1.0 in. Insulation
- 0.025 in. aluminum weather jacket
- 0.5 in./sec. scan rate
- External corrosion (2 in. dia.; 20% and 35%)

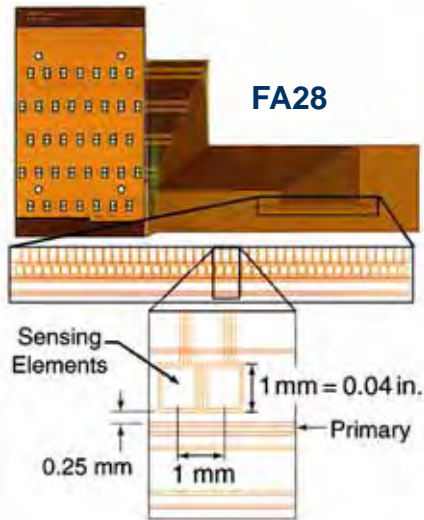


### Detection of Internal Corrosion

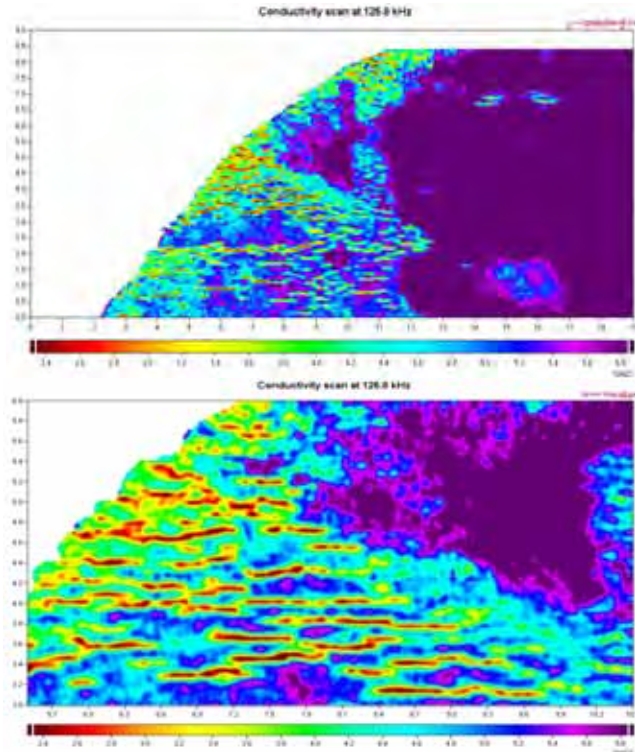


# FA28 MWM-Array Imaging of SCC

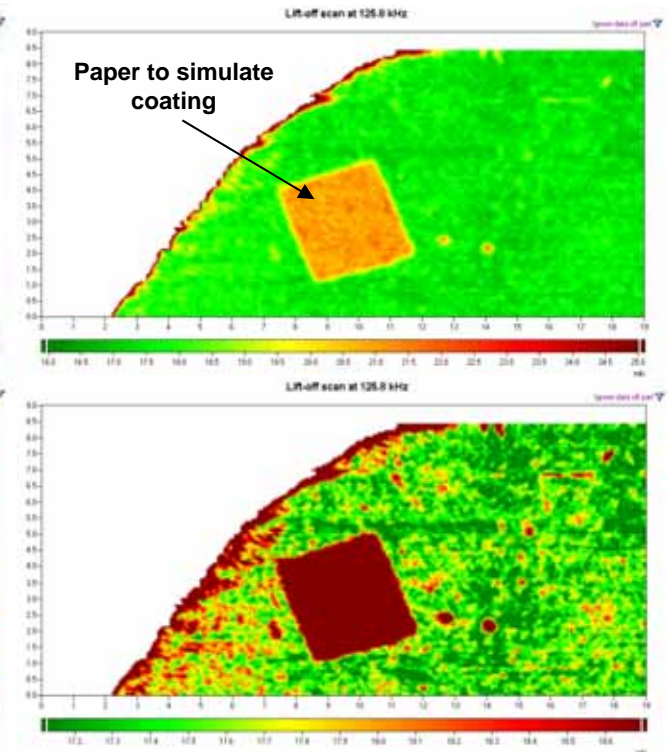
Pipeline Sample Provided by  
Applus/RTD



## Conductivity Images



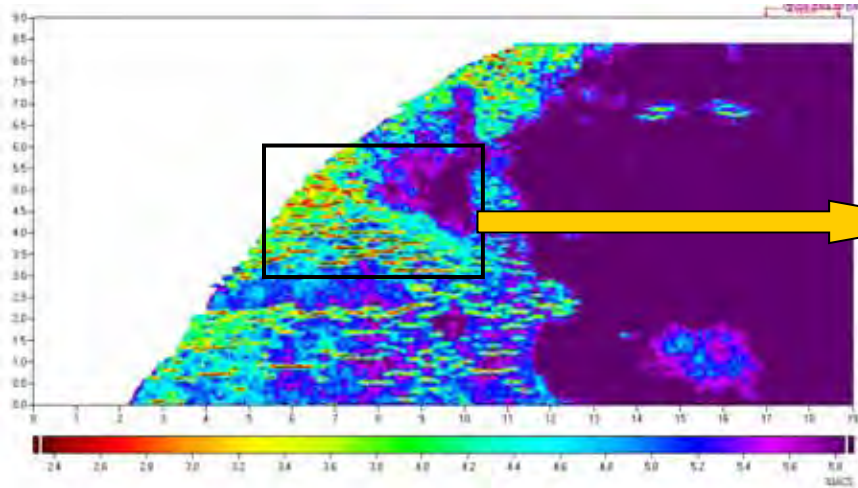
## Lift-Off Images



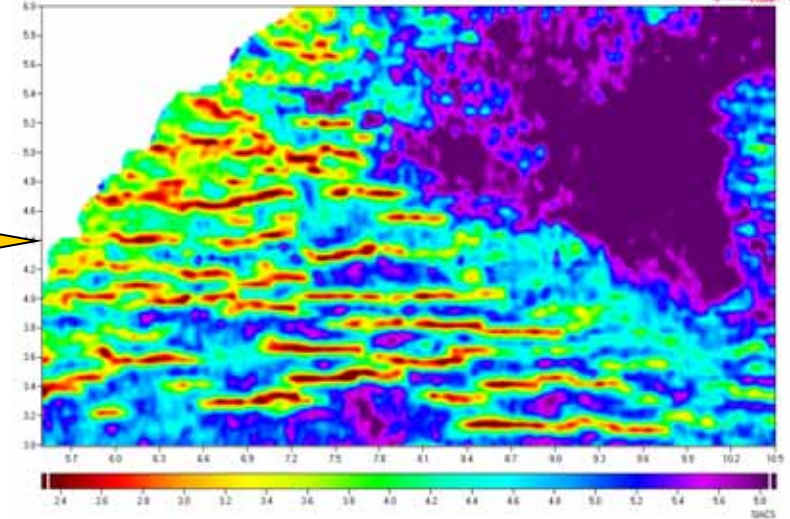


# FA28 Imaging of Stress Corrosion Cracking

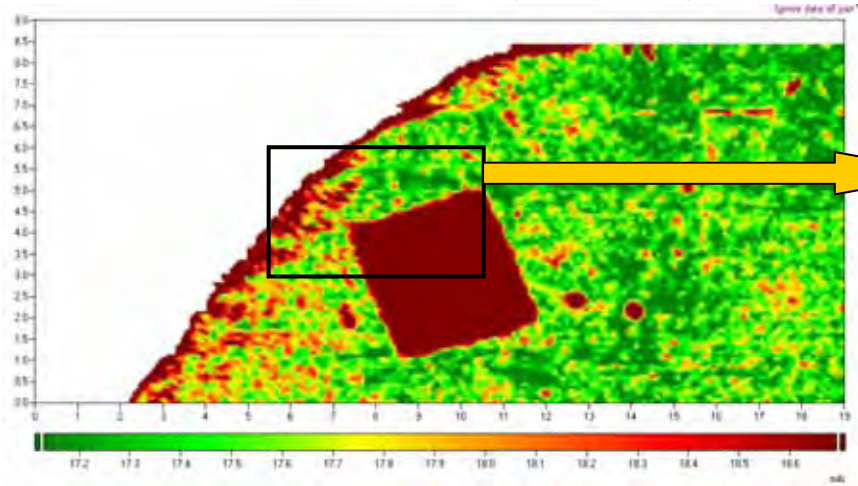
Conductivity Scan



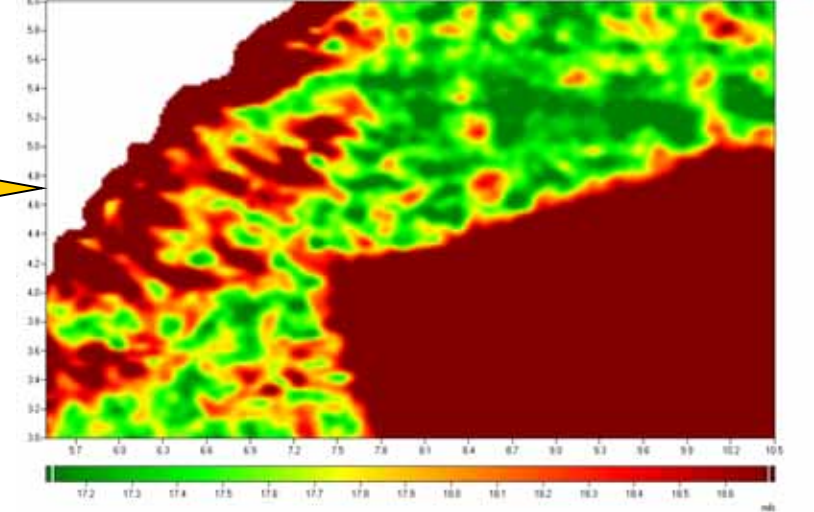
Close-Up of Conductivity Scan



Lift-Off Scan - Through Coating



Close-Up of Lift-Off Scan

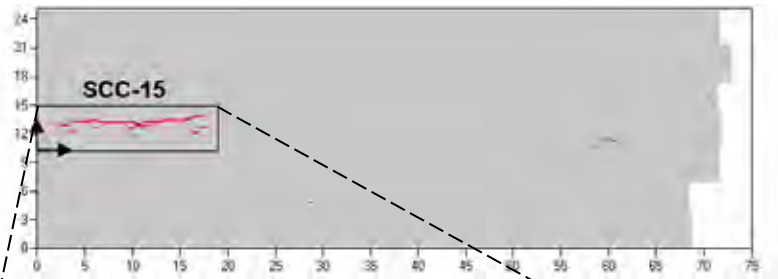


# FA28 Imaging of SCC in Pipeline Sample

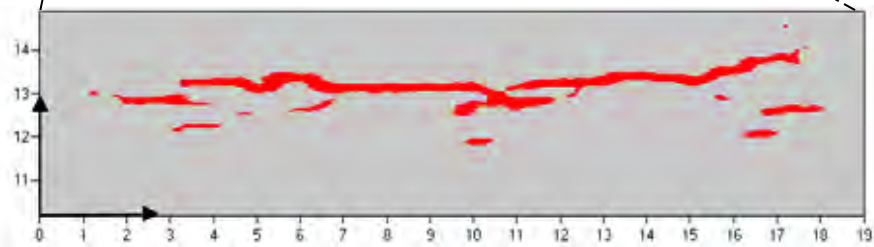
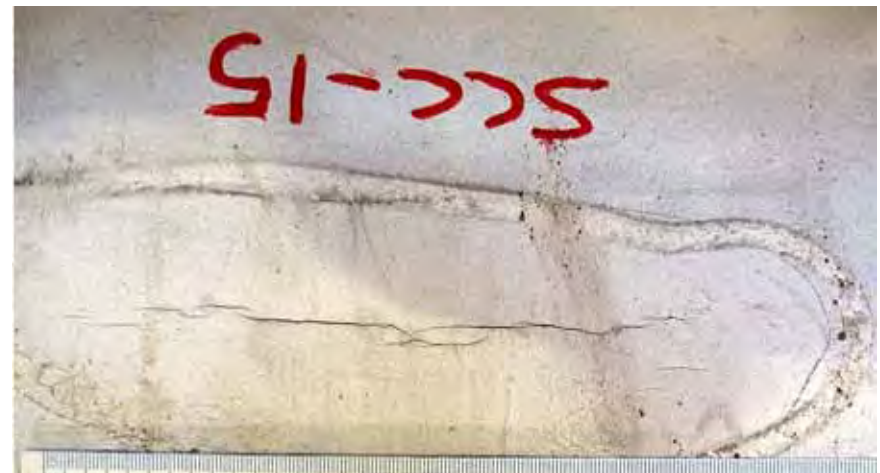
## Scans of Pipe Section with Identified SCC



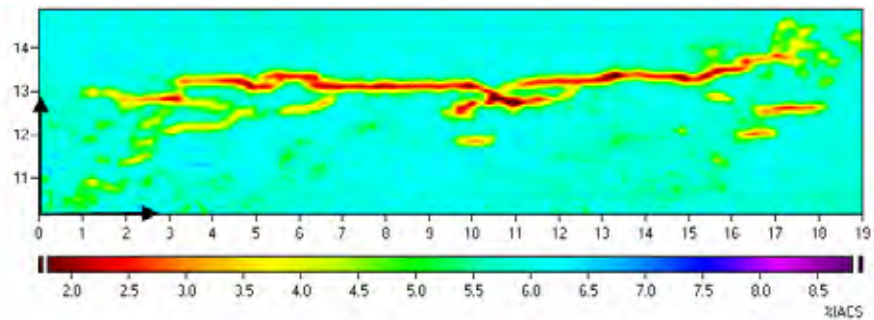
(RTD p/n NPS34 #1)



MWM-Array Threshold Image

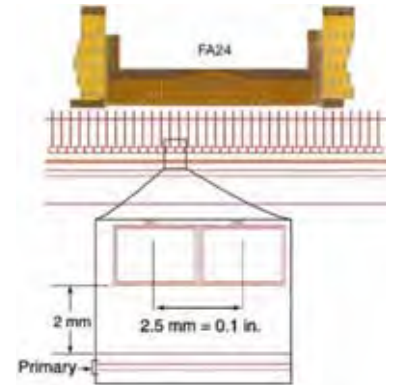


MWM-Array Spectrum Color Image

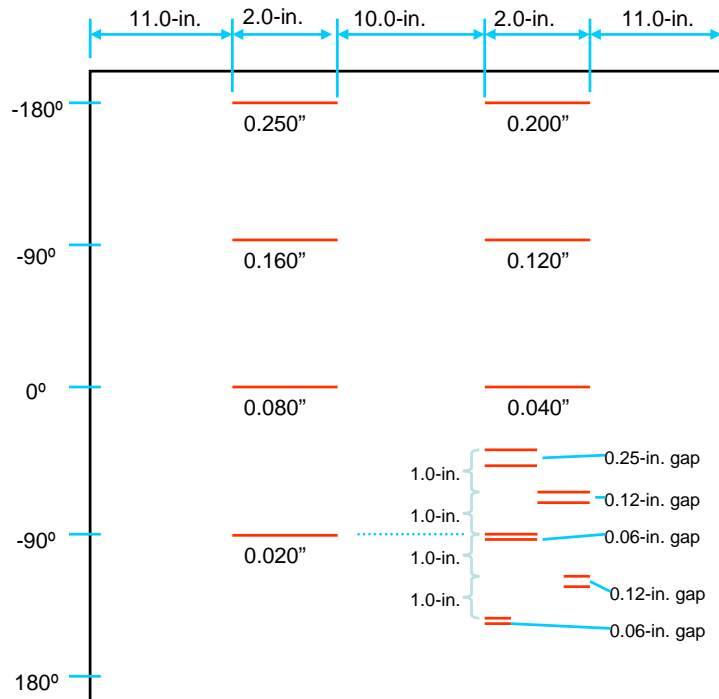


# EDM Notch Pipe Samples

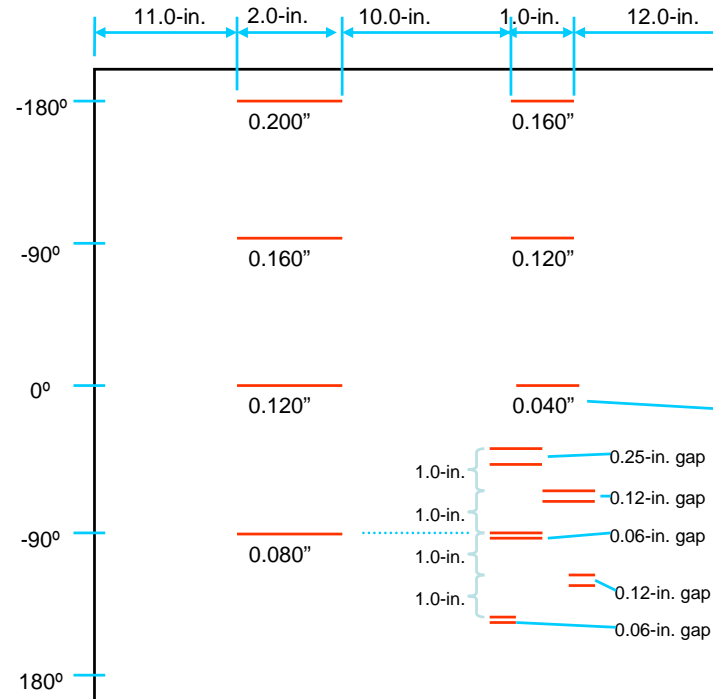
- 36-in. long, 8-in. diameter pipes
- Axial EDM notches located at various positions around each pipe
- Scanned with FA24 (medium size) MWM-Array
  - Wider array and sense elements compared to FA26



### Schedule 80 Sample



### Schedule 40 Sample



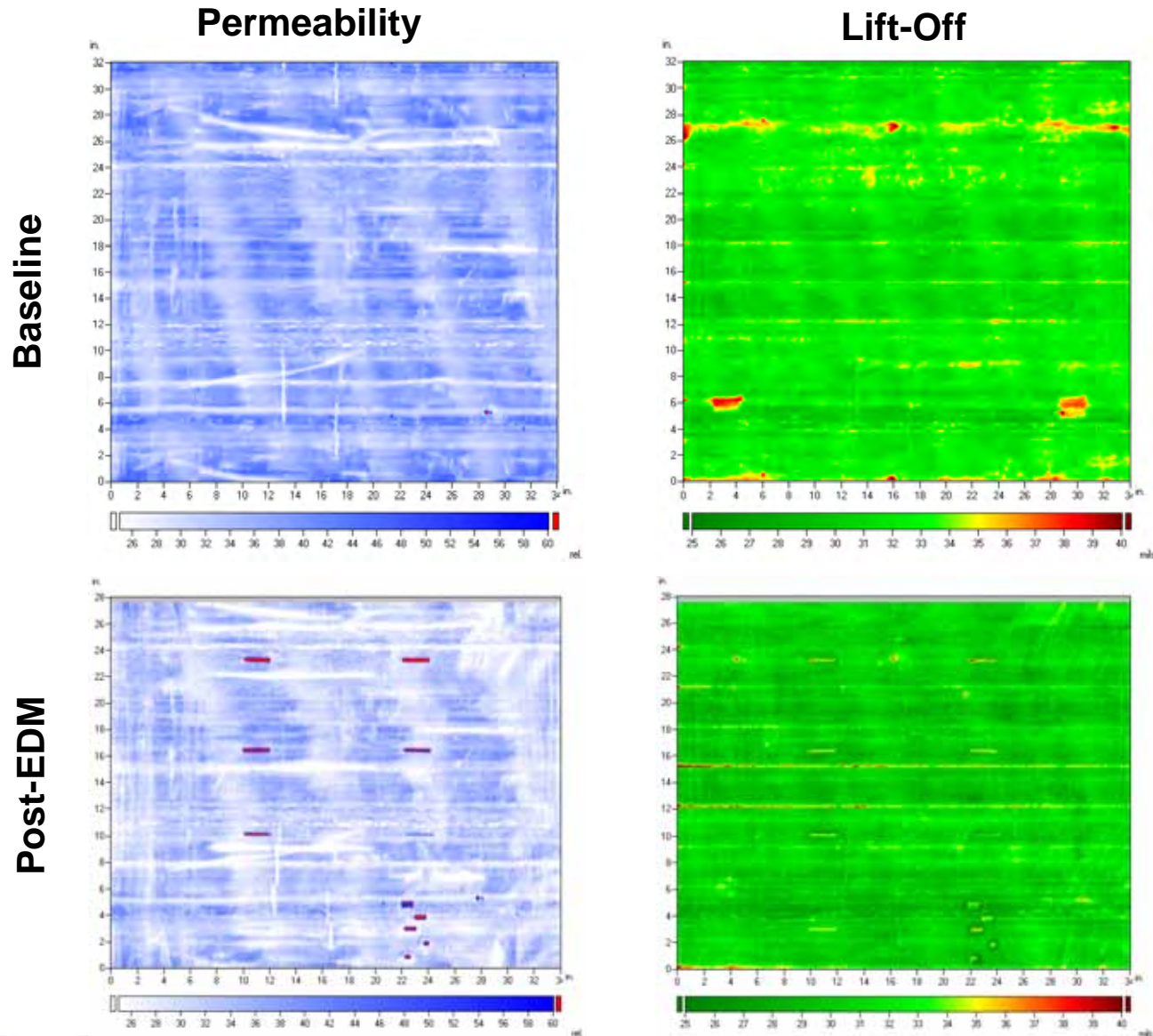
Depth of notch is indicated

Pairs of notches, either 0.5-in. or 1.0-in. long, each notch being 0.080" deep (sched. 80) or 0.040" deep (schedule 40). The vertical spacing is indicated.



# FA24 MWM-Array Scan of EDM Notch Pipe Sample

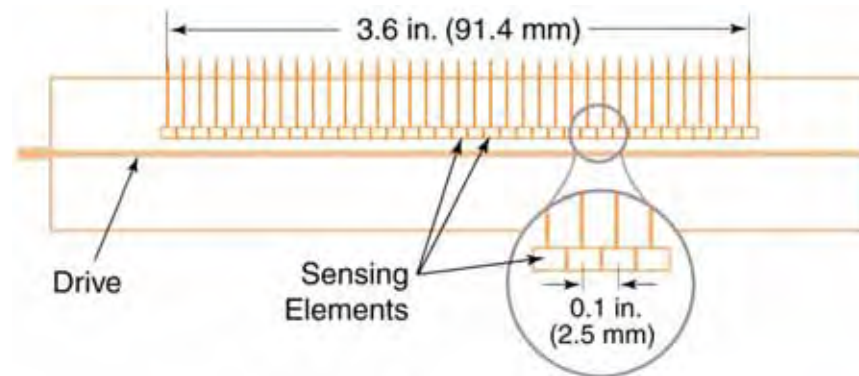
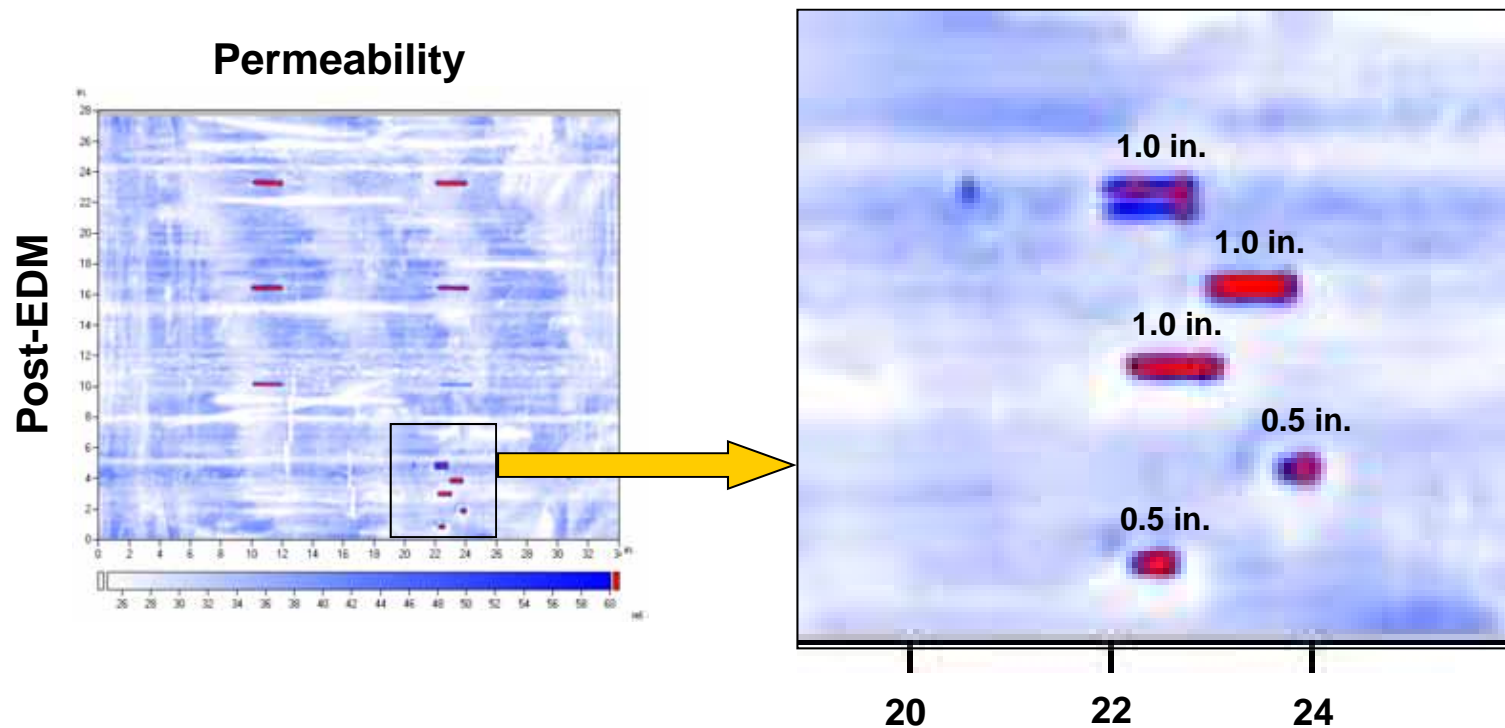
## Baseline & Post-EDM Fabrication Data on Schedule 80 Sample





# FA24 MWM-Array Scan of EDM Notch Pipe Sample

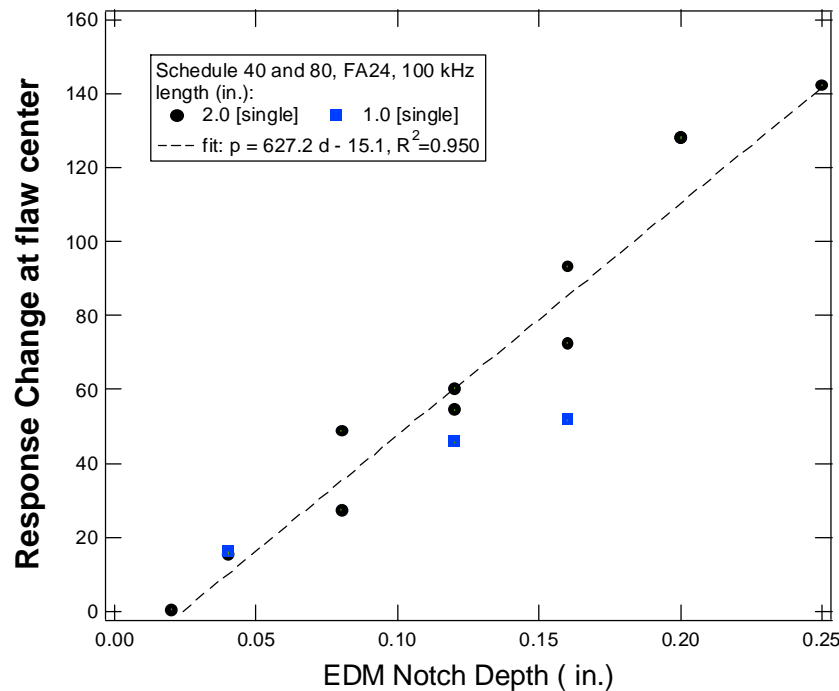
## Baseline & Post-EDM Fabrication Data on Schedule 80 Sample



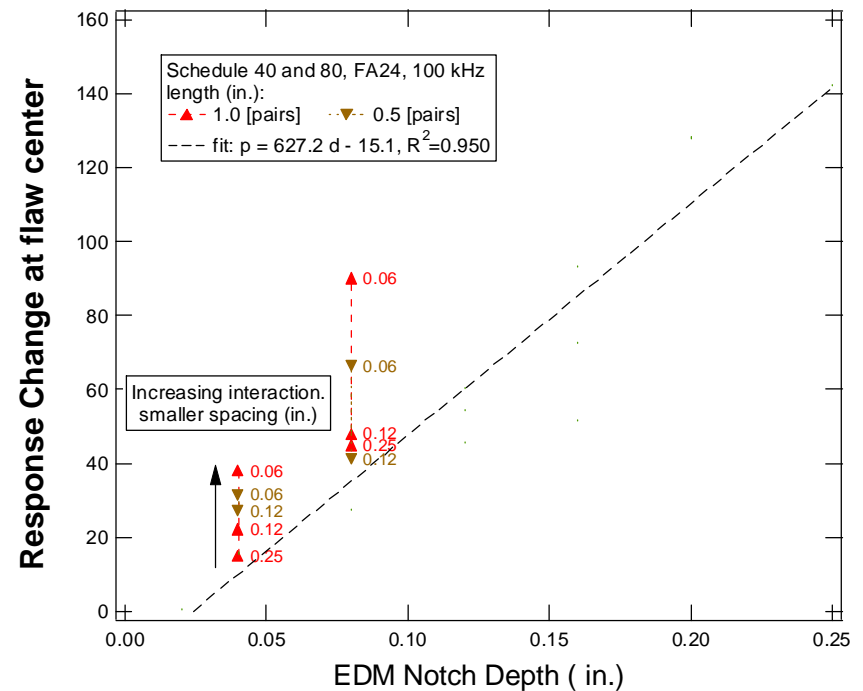
# Response Variations with Notch Depth

- FA24 (medium size) MWM-Array scan results
- Sensitive to notch depth over this range
- Nearby notches can lead to interacting responses

### Single Crack

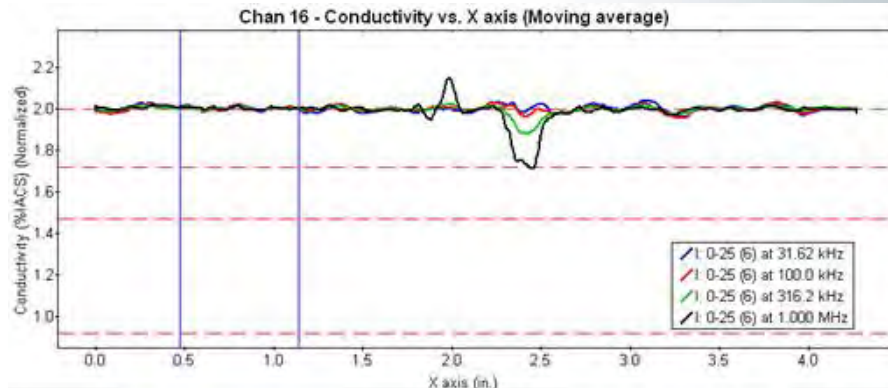


### Crack Clusters



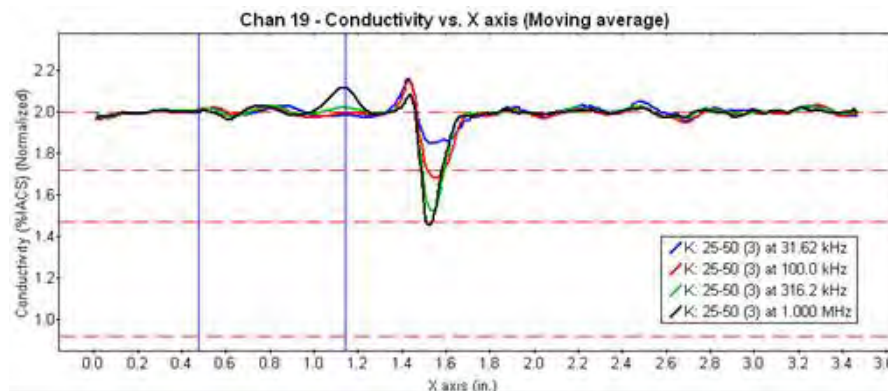
# Imaging and Characterization of Pitting

## FA24 Imaging of Stainless Steel Tubes



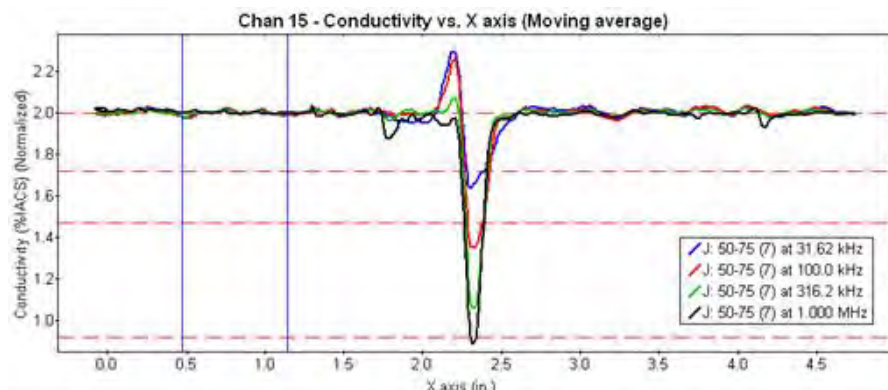
Pit I

0% - 25%



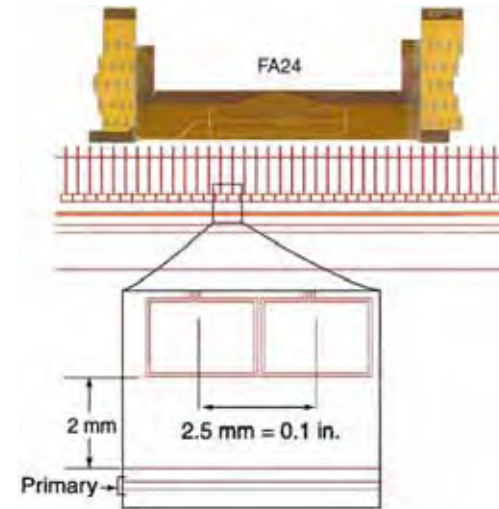
Pit K

25% - 50%



Pit J

50% - 75%

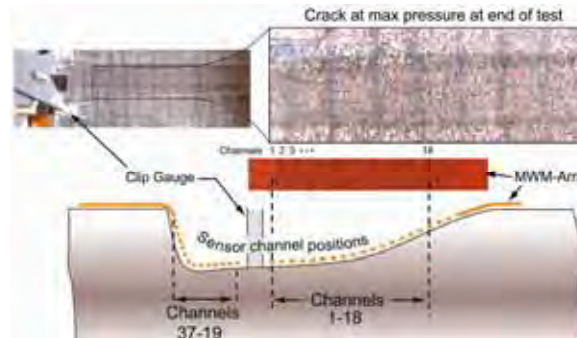


- High frequency imaging of surface breaking pits in stainless steel tubing
- Development of a pit depth algorithm is ongoing
- Actual depth of representative defects are needed

# DOT/PRCI Test by JENTEK

at GDF Suez Research & Innovation Division (CRIGEN) in St. Denis, France

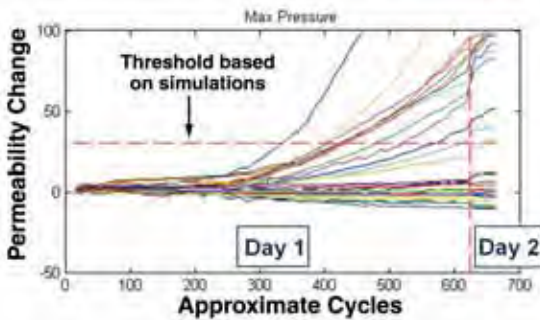
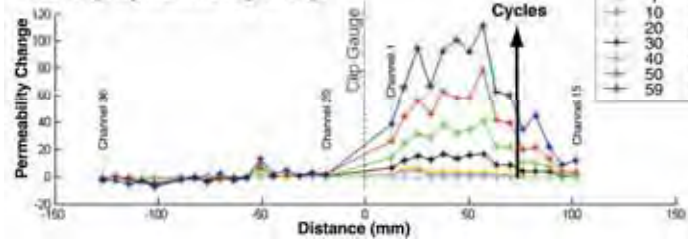
Previous success under DOT and PRCI funding with GDF Suez



FA178 MWM-Arrays

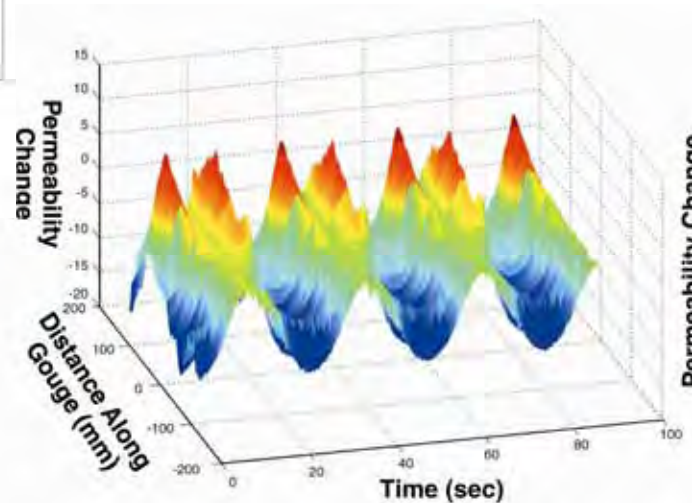
## Damage Monitoring

During dynamic cycling

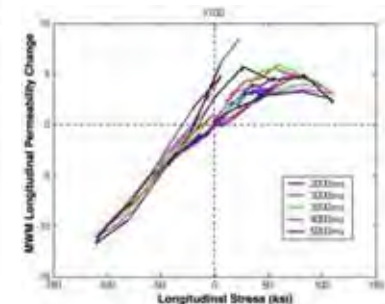


## Stress Monitoring

Dynamic pipeline pressure testing



4-pt static load testing of coupon





# JENTEK ILI Development

## Generation 1 - 2010

Preliminary capability demonstration in December 2010

- Small MWM-Array mounted on a tool and pulled through straight sections
- High freq. test to help understand issues for integrating sensors into an ILI tool



## Generation 2 - 2011

Enhanced capability demonstration September 2011

- Large MWM-Arrays to accommodate larger lift-offs (e.g., 0.25-1.00 in.)
- Integrated electronics with only power supply tether (24v)



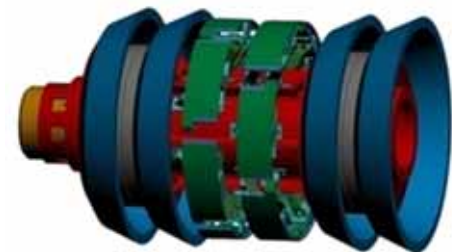
## Generation 3 – 2012/2013

Increased number of channels to provide complete coverage

Higher data throughput per channel to increase the maximum speed of the tool through the pipe

Include on-board power onto tool and reduce power consumption for battery operation of instrumentation

Improved durability and hardening of the instrument, including isolation from the environment.



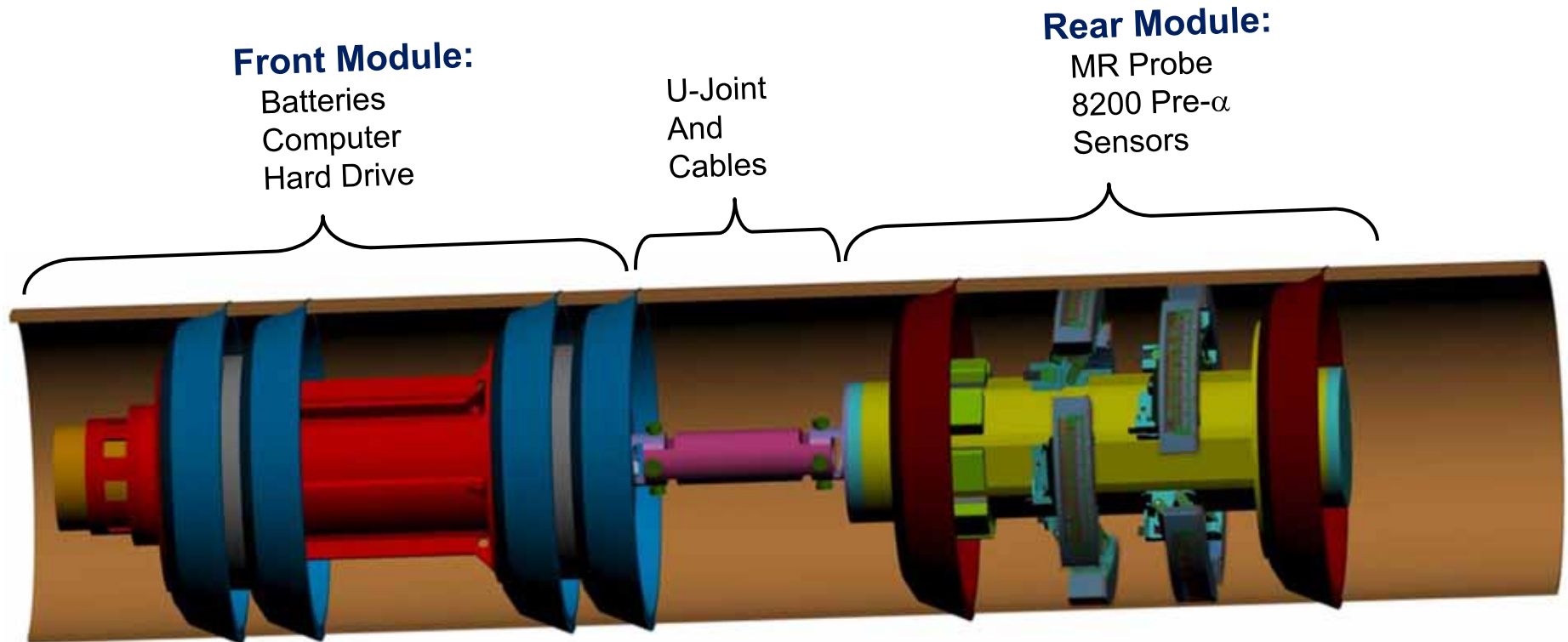
## Generation 4 – 2013/2014

Integrate low frequency measurement technology for pipeline wall thickness measurements for detection of external corrosion and mechanical damage

Improved durability and hardening of the instrument, including sealing for environmental protection in oil and gas environments and shock protection

# Generation 3 Technology

## Preliminary Design



- **72 channels**
- **>5000 measurements/sec./channel**
- **Full circumferential coverage**
- **Internal corrosion and internal profilometry**

# Generation 2 Technology

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## Enhanced capability demonstration in September 2011

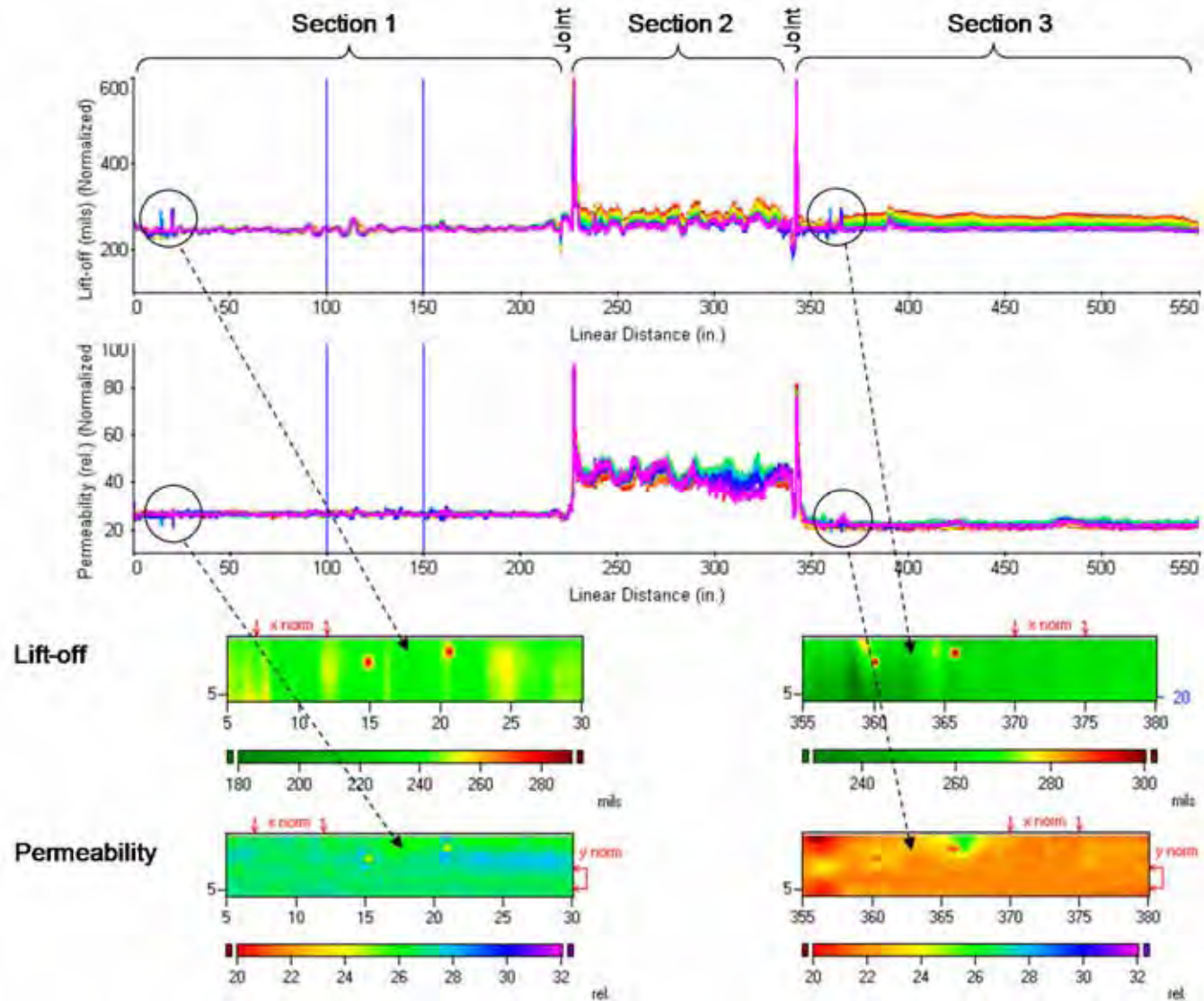
- Two medium MWM-Arrays (VWA005) mounted on a 2<sup>nd</sup> generation tool for straight sections
- Larger MWM-Arrays to accommodate larger lift-offs (e.g., 0.25-in.)
- Integrated electronics with only power supply tether
- Similar flaw images as pull Test 1, but both sides imaged at same time
- Generally see local change in effective lift-off and permeability for flaws



# Generation 2 Technology

## Pull Test Results

MWM-Array 2  
Pull Speed:  
~0.36 mph





# Summary

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- MWM-Array technology provides a flexible model-based eddy-current array for imaging of pipeline material condition
- Demonstrated capabilities for numerous applications
  - Pipe wall thickness measurement through coatings/insulation
  - Underwater inspections (shallow water and deepsea) for pipe wall thickness measurement
  - SCC mapping and crack depth estimation
  - Characterization of pitting in stainless steel tubing
  - Permanently mounted sensors for continuous monitoring
  - In-line inspection (ILI)



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# Questions?

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